Search Notes		

Application/Control No.	Applicant(s)/Patent (under
10/621,176	FERLITSCH, ANDF	REW
Examiner	Art Unit	
Thomas D. Lee	2625	

SEARCHED				
Class	Subclass	Date	Examiner	
358	1.1, 1.15, 400, 401, 407, 442	4/26/2007	TDL	
358	468	4/26/2007	TDL	
379	100.01	4/26/2007	TDL	
379	100.09	4/26/2007	TDL	
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST Search History Printout	4/26/2007	TDL
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